

Search Notes

Application/Control No.

10/531,987

Examiner

Shin Kim

Applicant(s)/Patent under
Reexamination

NICHOLINI ET AL.

Art Unit

3611

SEARCHED

Class	Subclass	Date	Examiner
40	541	1/27/2007	SK
40	452	1/27/2007	gle
40	564	1/27/2007	gle
40	570	1/27/2007	382

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR